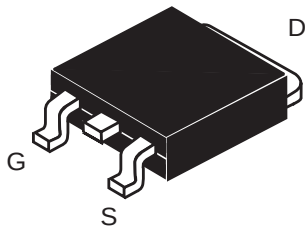
South Sea Semiconductor

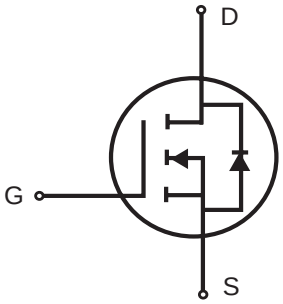
SSD2030N

N-Channel Enhancement Mode MOSFET

Product Summary		
V_{DS} (V)	I_D (A)	$R_{DS(ON)}$ (mΩ) Max
30V	20A	30 @V_{GS} = 10V
		55 @V_{GS} = 4.5V

TO-252





FEATURES

- Super high dense cell design for low $R_{DS(ON)}$.
- Rugged and reliable.
- TO-252 package.

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)			
Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	±20	V
Drain Current-Continuous @ T_C = 25°C	I_D	20	A
-Pulsed [b]	I_{DM}	60	A
Drain-Source Diode Forward Current [a]	I_S	20	A
Maximum Power Dissipation[a] @T_C = 25°C	P_D	50	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	°C
THERMAL CHARACTERISTICS			
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	3	°C/W
Thermal Resistance, Junction-to-Ambient [a]	$R_{\theta JA}$	50	

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Electrical Characteristics (T_A = 25℃ unless otherwise noted)						
Parameter	Symbol	Condition	Min	Typ[c]	Max	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS}=0V, I_D=250μA	30			V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS}=24V, V_{GS}=0V			1	μA
Gate-Body Leakage	I_{GSS}	V_{GS}=±20V, V_{DS}=0V			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}=V_{GS} I_D=250μA	1	1.7	2.5	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	V_{GS}=10V, I_D=20A		23	30	mΩ
		V_{GS}=4.5V, I_D=10A		47	55	
On-State Drain Current	$I_{D(ON)}$	V_{DS}=5V, V_{GS}=10V	45			A
Forward Transconductance	g_{FS}	V_{DS}=5V, I_D=7A		8		S
Input Capacitance	C_{ISS}	V_{DS}=15V		590		pF
Output Capacitance	C_{OSS}	V_{GS}=0V		108		
Reverse Transfer Capacitance	C_{RSS}	f=1.0MHz		80		
Turn-On Delay Time	$t_{D(ON)}$	V_{DD}=15V,		9		ns
Rise Time	t_r	I_D=1A,		16		
Turn-Off Delay Time	$t_{D(OFF)}$	V_{GS}=10V,		17		
Fall Time	t_f	R_{GEN}=10Ω,		11		
Total Gate Charge	Q_g	V_{DS}=15V, I_D=1A, V_{GS}=10V		13		nC
		V_{DS}=15V, I_D=1A, V_{GS}=4.5V		6.5		
Gate-Source Charge	Q_{gs}	V_{DS}=15V, I_D=1A, V_{GS}=10V		2.5		
Gate-Drain Charge	Q_{gd}			3		
Diode Forward Voltage	V_{SD}	V_{GS}=0V, I_D=20A		1	1.3	V

Notes：

a. Surface Mounted on FR4 Board, t ≤10 sec.

b. Pulse Test：Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

c. Guaranteed by design, not subject to production testing.

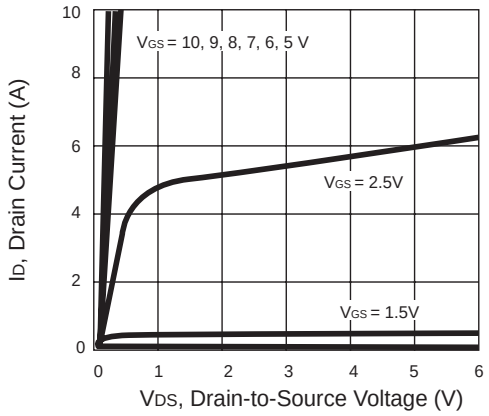


Figure 1. Output Characteristics

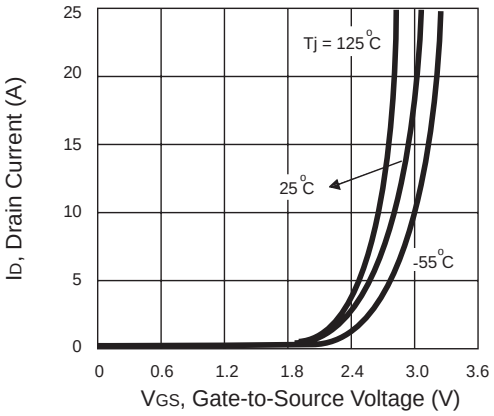


Figure 2. Thansfer Characteristics

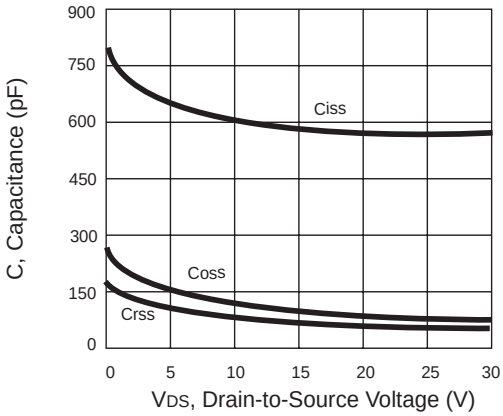


Figure 3. Capacitance

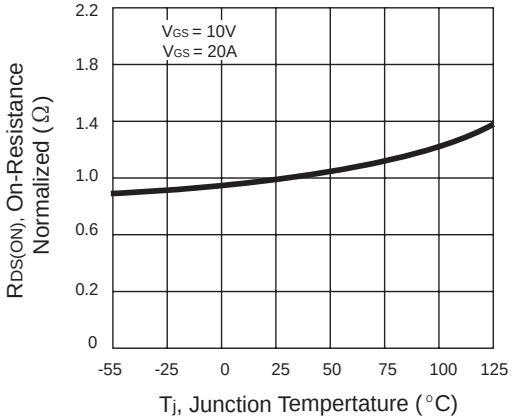


Figure 4. On-Resistance Variation with Temperature

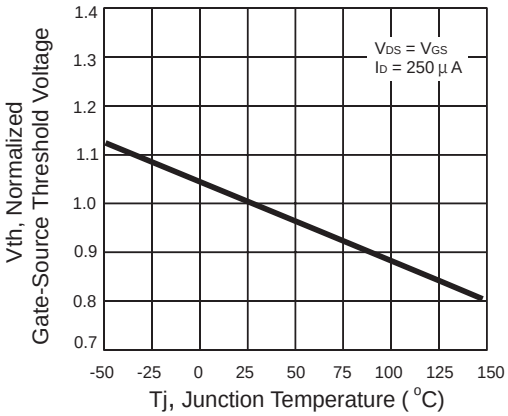


Figure 5. Gate Threshold Variation with Temperature

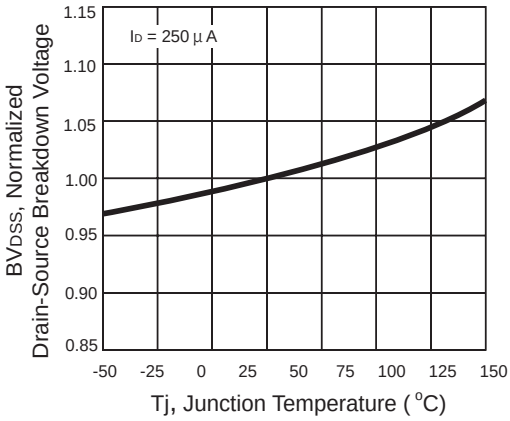


Figure 6. Breakdown Voltage Variation with Temperature

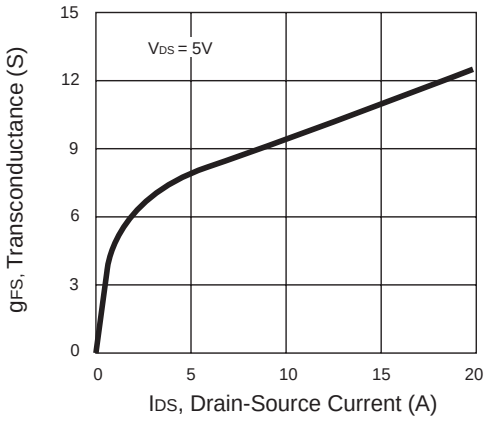


Figure 7. Transconductance Variation with Drain Current

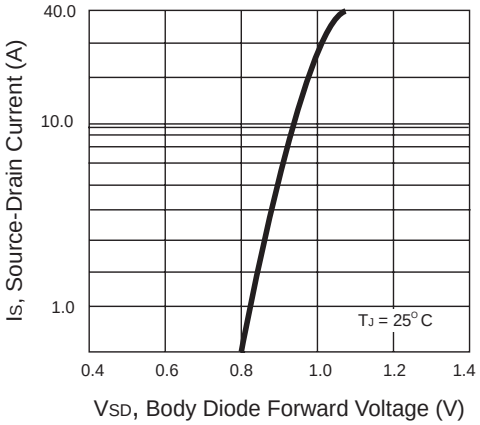


Figure 8. Body Diode Forward Voltage Variation with Source Current

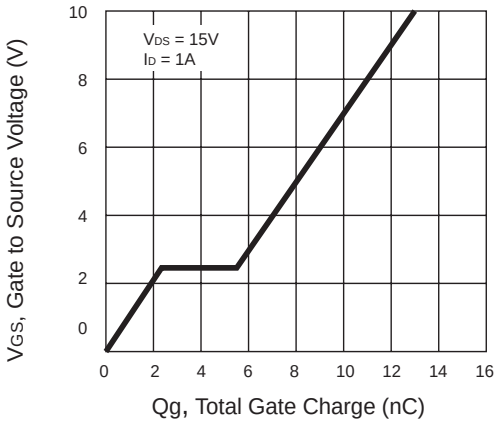


Figure 9. Gate Charge

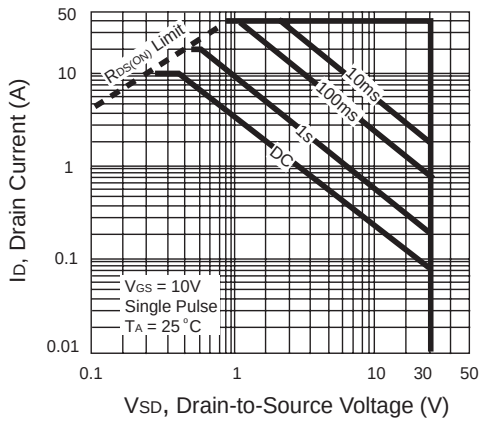


Figure 10. Maximum Safe Operating Area

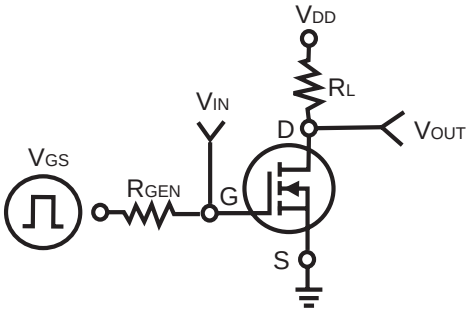


Figure 11. Switching Test Circuit

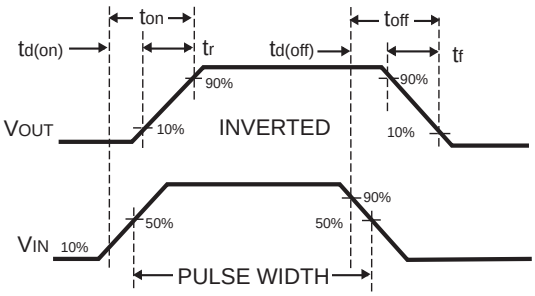


Figure 12. Switching Waveforms

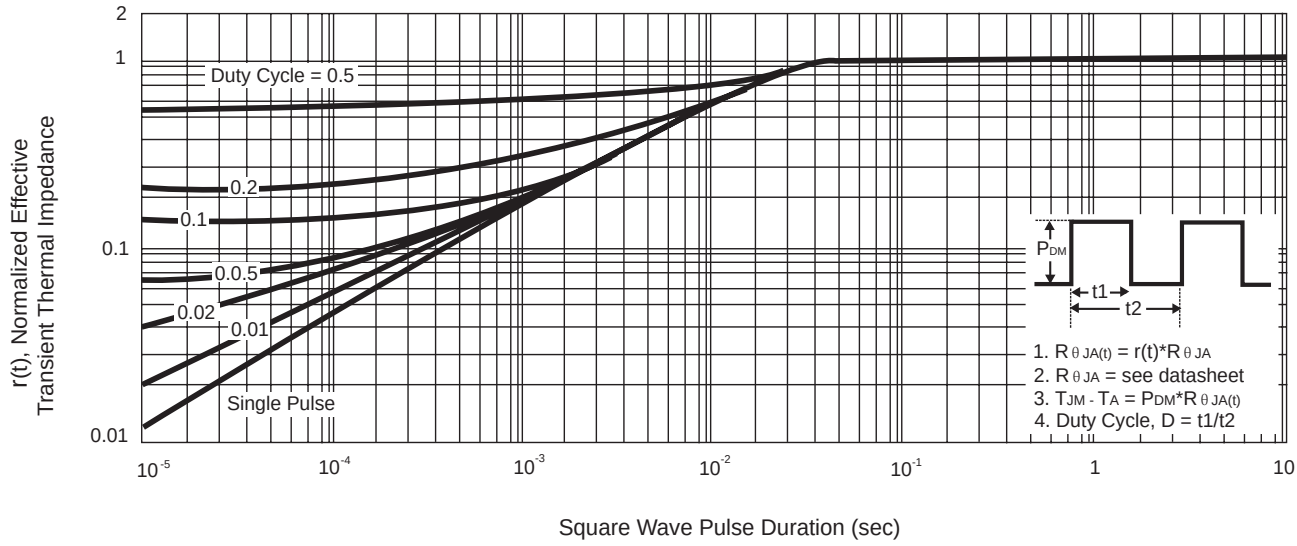
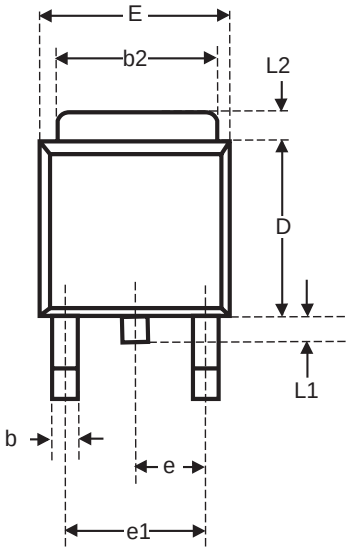
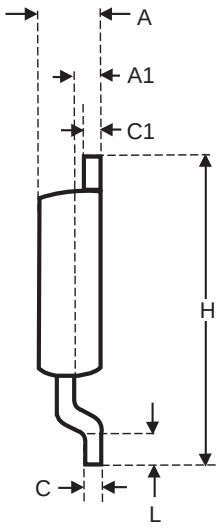


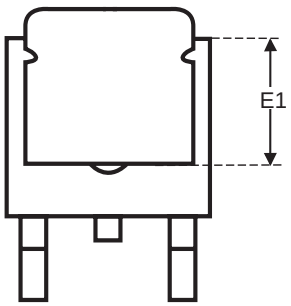
Figure 13. Normalized Thermal Transient Impedance Curve

Package Outline Dimensions

TO-252



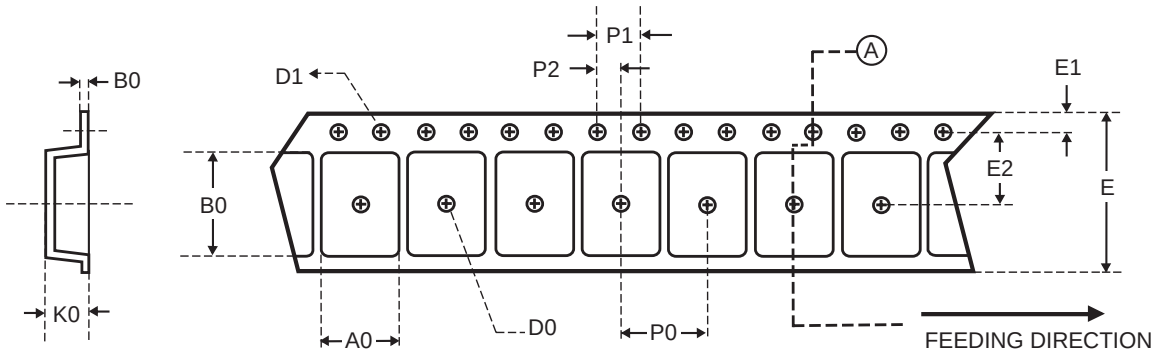




SYMBOLS	MILLIMETERS		INCHES	
	Min.	Max.	Min.	Max.
A	2.25	2.35	0.089	0.093
A1	0.95	1.05	0.037	0.041
b	0.77	0.85	0.030	0.033
b2	5.30	5.45	0.209	0.215
C	0.49	0.53	0.019	0.021
D	6.00	6.20	0.236	0.244
E	6.40	6.60	0.252	0.260
E1	3.18	3.67	0.125	0.145
e	2.29 BSC		0.090 BSC	
H	9.70	10.10	0.382	0.398
L	1.425	1.625	0.056	0.064
L1	0.650	0.850	0.026	0.033
L2	0.600 REF.		0.024 REF.	

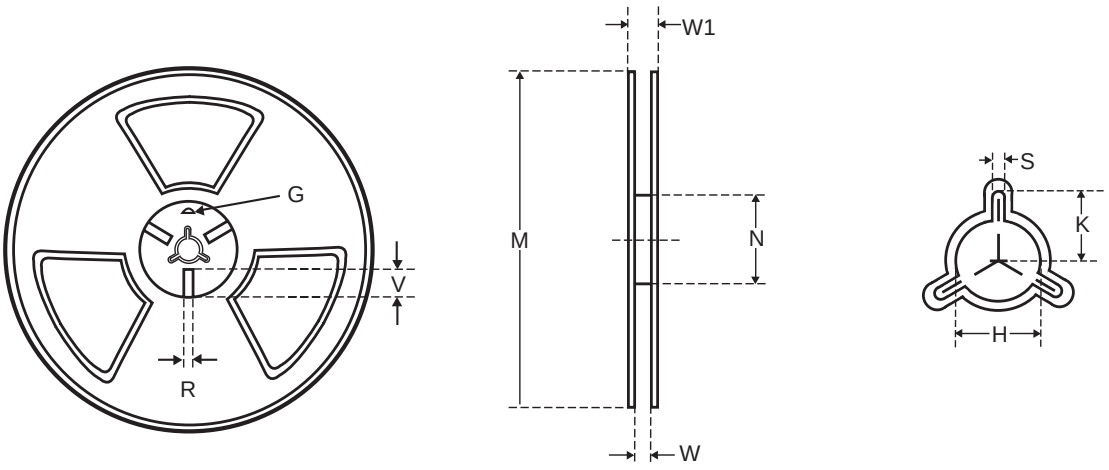
Carrier Tape & Reel Dimensions

TO-252



Package	A0	B0	K0	D0	D1	E	E1	E2	P0	P1	P2	T
TO-252	6.80 ± 0.10	10.30 ± 0.10	2.50 ± 0.10	ψ2.00	ψ1.50 +0.10 −0.00	16.00 ± 0.30	1.75 ± 0.10	7.50 ± 0.15	8.00 ± 0.10	4.00 ± 0.10	2.00 ± 0.15	0.30 ± 0.05

UNIT：mm



Tape size	Reel Size	M	N	W	W1	H	K	S	G	R	V
16 mm	ψ330	ψ330 ± 0.5	ψ 97 ± 1	17.0 +1.5 −0.0	21.4 +1.5 −0.0	ψ13.0 +0.5 −0.2	10.6	2.0 ±0.5	−	−	−

UNIT：mm